

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination		
				09/909,383		TAGUCHI, AKIRA		
				Examiner		Art Unit		
				Shin-Hon Chen		2131		

ISSUE CLASSIFICATION										
ORIGINAL		CROSS REFERENCE(S)								
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
726	18	726	2	4	18	19	28	29	30	
INTERNATIONAL CLASSIFICATION		379	70	88						
G	0 6 F	7/04	340	825						
G	0 6 F	7/58								
G	0 6 F	12/00								
G	0 6 F	12/14								
G	0 6 F	13/00								
<i>Sh-Hon Chen 3/2/06</i> (Assistant Examiner) (Date)				<i>M. M. Sheikh</i> AYAZ SHEIKH SUPERVISORY PATENT EXAMINER <small>(Primary Examiner)</small> TECHNOLOGY CENTER 2100 <i>3/3/06</i>					Total Claims Allowed: 9	
<i>O. H. Sheik</i> <small>Legal Instruments Examiner</small> <i>3/3/06</i> (Date)									O.G. Print Claim(s)	O.G. Print Fig.
									1	2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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4	4	34	64	94	124	154	184
5	5	35	65	95	125	155	185
6		36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9		39	69	99	129	159	189
6	10	40	70	100	130	160	190
9	11	41	71	101	131	161	191
12		42	72	102	132	162	192
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14		44	74	104	134	164	194
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26		56	86	116	146	176	206
27		57	87	117	147	177	207
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